Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination MEIER ET AL.	
09/425,992		
Examiner	Art Unit	

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2673

SEARCHED					
Class	Subclass	Date	Examiner		
345	629	8/24/2001	PN		
	630	8/24/2001	PN		
	589	8/24/2001	PN		
	591	8/24/01	PN		
	634	8/24/2001	PN		
	419	8/24/2001	PN		
Update	search	1/20/2005	PN		
358	2.1	1/20/2005	PN		
	2.99	1/20/2005	PN		
382	284	1/20/2005	PN		
	276	1/20/2005	PN		
Update	search	8/5/2005	PN		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
345	629	8/6/2005	PN		
	630	8/6/2005	PN		
382	276	8/6/2005	PN		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST search see attached	1/10/2005	PN		
NonPatent Literature (IEEE, ACM) search SEE ATTACHED	1/10/2005	PN		
Inventor Name search	1/10/2005	PN		